Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/617,033	AMADA ET AL.
Examiner	Art Unit
Hai C. Pham	2861

SEARCHED			
Class	Subclass	Date	Examiner
347	235-239, 246-250, 255, 135	11/18/2005	НР
	136		
349	1-3	11/18/2005	HP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	-		

SEARC (INCLUDING SE	H NOTES ARCH STRATE	EGY)
	DATE	EXMR
EAST Text Search	11/18/20	005 HP